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# Analysis of Switching Transistor Characteristics

Terry L. Klinger

*Indiana University - Purdue University Fort Wayne*

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ANALYSIS OF SWITCHING TRANSISTOR CHARACTERISTICS

by

Terry L. Klinger

14 May 1970

EET 499

## Table of Contents

Section	Title	Page
1.0	INTRODUCTION .....	1-1
2.0	SWITCHING CHARACTERISTICS.....	2-1
2.1	Turn On Delay Time.....	2-1
2.2	Rise Time.....	2-7
2.3	Storage Time.....	2-11
2.4	Fall Time.....	2-16
3.0	CIRCUITS TO IMPROVE SWITCHING SPEED.....	3-1
3.1	Delay Time Improvements.....	3-1
3.2	Rise Time Improvements.....	3-2
3.3	Storage Time Improvements.....	3-3
3.4	Fall Time Improvements.....	3-4
3.5	Optimum Circuit.....	3-5
4.0	TEST CIRCUIT CONSIDERATIONS.....	4-1
4.1	Electrical Design Considerations.....	4-1
4.2	Mechanical Design Considerations.....	4-5
5.0	EXPERIMENTAL TESTS AND RESULTS FOR A 2N1131.....	5-1
5.1	Measured Switching Times Versus $V_1$ , $V_2$ , and $V_{CE}$ .....	5-1
5.2	Measured Switching Times With Improvement Circuits.....	5-1
5.3	Switching Times Versus Temperature.....	5-22
6.0	SUMMARY.....	6-1
APPENDIX A	Graphical Integration to Obtain $Q_{OB}$ .....	A-1
APPENDIX B	Experimental Determination of $\tau_s$ .....	B-1
APPENDIX C	Specification Sheets of 2N1131	